

Dual P-channel MOSFET

ELM14807AA-N

■ General description

ELM14807AA-N uses advanced trench technology to provide excellent R_{d(on)} and low gate charge.

■ Features

- V_{ds}=-30V
- I_d=-6A (V_{gs}=-10V)
- R_{d(on)} < 35mΩ (V_{gs}=-10V)
- R_{d(on)} < 58mΩ (V_{gs}=-4.5V)

■ Maximum absolute ratings

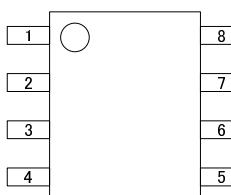
Parameter	Symbol	Limit	Unit	Note
Drain-source voltage	V _{ds}	-30	V	
Gate-source voltage	V _{gs}	±20	V	
Continuous drain current	I _d	-6	A	1
Ta=70°C		-5		
Pulsed drain current	I _{dm}	-30	A	2
Power dissipation	P _d	2.00	W	1
Ta=70°C		1.44		
Junction and storage temperature range	T _j , T _{stg}	-55 to 150	°C	

■ Thermal characteristics

Parameter		Symbol	Typ.	Max.	Unit	Note
Maximum junction-to-ambient	t≤10s	R _{θja}	48.0	62.5	°C/W	1
Maximum junction-to-ambient	Steady-state		74.0	110.0	°C/W	
Maximum junction-to-lead	Steady-state	R _{θjl}	35.0	40.0	°C/W	3

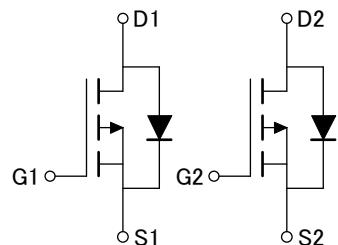
■ Pin configuration

SOP-8 (TOP VIEW)



Pin No.	Pin name
1	SOURCE2
2	GATE2
3	SOURCE1
4	GATE1
5	DRAIN1
6	DRAIN1
7	DRAIN2
8	DRAIN2

■ Circuit



Dual P-channel MOSFET

ELM14807AA-N

■ Electrical characteristics

$T_a=25^\circ C$

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
STATIC PARAMETERS						
Drain-source breakdown voltage	BVdss	$Id=-250\ \mu A, Vgs=0V$	-30			V
Zero gate voltage drain current	Idss	$Vds=-24V$ $Vgs=0V$			-1 -5	μA
Gate-body leakage current	Igss	$Vds=0V, Vgs=\pm 20V$			± 100	nA
Gate threshold voltage	Vgs(th)	$Vds=Vgs, Id=-250\ \mu A$	-1.2	-2.0	-2.4	V
On state drain current	Id(on)	$Vgs=-10V, Vds=-5V$	-30			A
Static drain-source on-resistance	Rds(on)	$Vgs=-10V$ $Id=-6A$ $Vgs=-4.5V, Id=-5A$		28 37 44	35 45 58	$m\Omega$
Forward transconductance	Gfs	$Vds=-5V, Id=-6A$		13		S
Diode forward voltage	Vsd	$Is=-1A, Vgs=0V$		-0.76	-1.00	V
Max. body-diode continuous current	Is				-4.2	A
DYNAMIC PARAMETERS						
Input capacitance	Ciss			920		pF
Output capacitance	Coss	$Vgs=0V, Vds=-15V, f=1MHz$		190		pF
Reverse transfer capacitance	Crss			122		pF
Gate resistance	Rg	$Vgs=0V, Vds=0V, f=1MHz$		3.6		Ω
SWITCHING PARAMETERS						
Total gate charge (10V)	Qg			18.5		nC
Total gate charge (4.5V)	Qg	$Vgs=-10V, Vds=-15V$		9.6		nC
Gate-source charge	Qgs	$Id=-6A$		2.7		nC
Gate-drain charge	Qgd			4.5		nC
Turn-on delay time	td(on)			7.7		ns
Turn-on rise time	tr	$Vgs=-10V, Vds=-15V$		5.7		ns
Turn-off delay time	td(off)	$Rl=2.7\ \Omega, Rgen=3\ \Omega$		20.2		ns
Turn-off fall time	tf			9.5		ns
Body diode reverse recovery time	trr	$If=-6A, dl/dt=100A/\mu s$		20.0		ns
Body diode reverse recovery charge	Qrr	$If=-6A, dl/dt=100A/\mu s$		8.8		nC

NOTE :

1. The value of $R\theta_{ja}$ is measured with the device mounted on 1in² FR-4 board of 2oz. Copper, in still air environment with $T_a=25^\circ C$. The value in any given applications depends on the user's specific board design, The current rating is based on the $t \leq 10s$ thermal resistance rating.
2. Repetitive rating, pulse width limited by junction temperature.
3. The $R\theta_{ja}$ is the sum of the thermal impedance from junction to lead $R\theta_{jl}$ and lead to ambient.
4. The static characteristics in Figures 1 to 6 are obtained using 80 μs pulses, duty cycle 0.5%max.
5. These tests are performed with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_a=25^\circ C$. The SOA curve provides a single pulse rating.



Dual P-channel MOSFET

ELM14807AA-N

■ Typical electrical and thermal characteristics

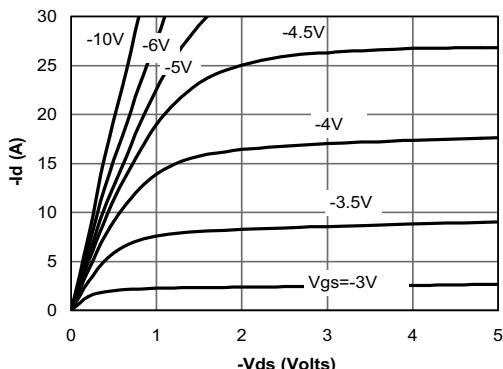


Fig 1: On-Region Characteristics

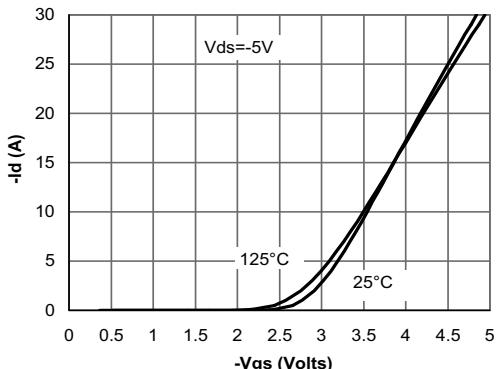


Figure 2: Transfer Characteristics

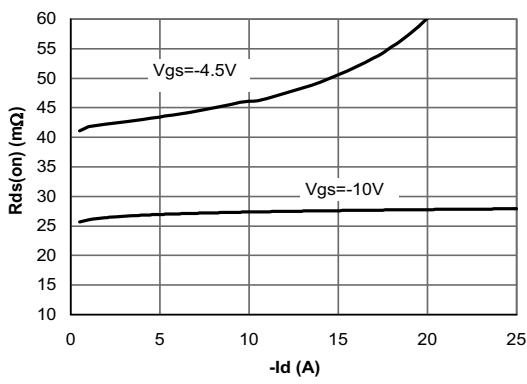


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

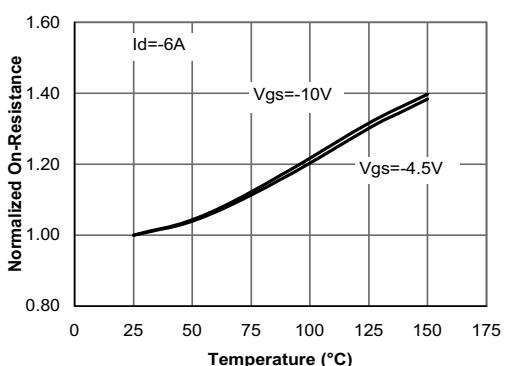


Figure 4: On-Resistance vs. Junction Temperature

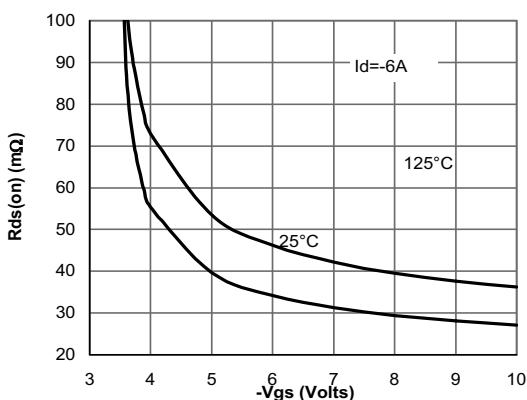


Figure 5: On-Resistance vs. Gate-Source Voltage

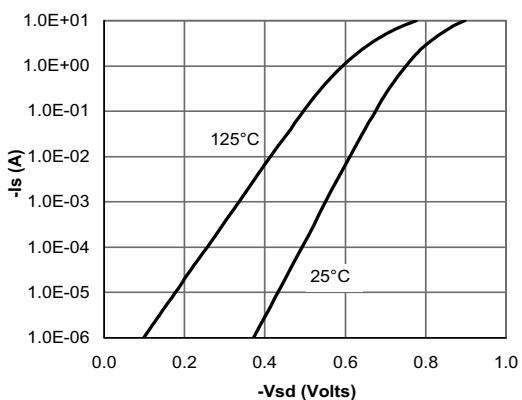


Figure 6: Body-Diode Characteristics

Dual P-channel MOSFET

ELM14807AA-N

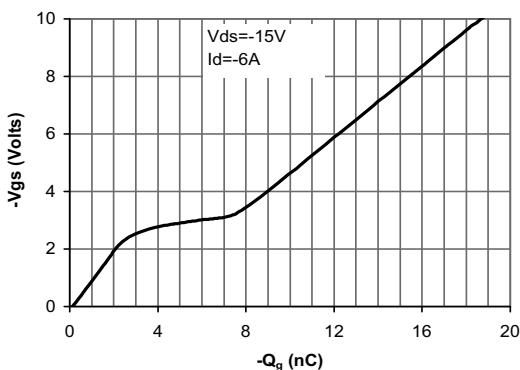


Figure 7: Gate-Charge Characteristics

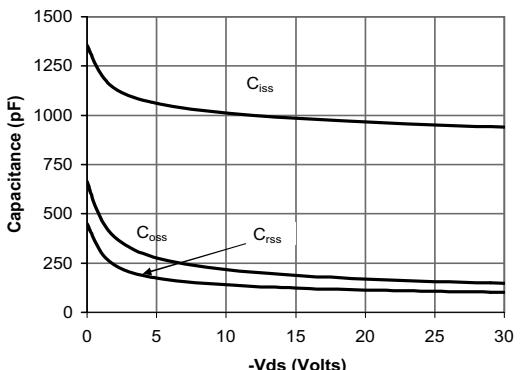


Figure 8: Capacitance Characteristics

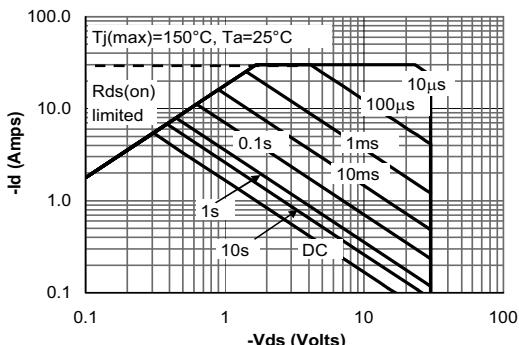


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

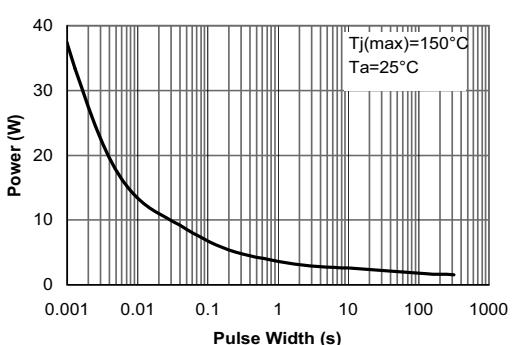


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

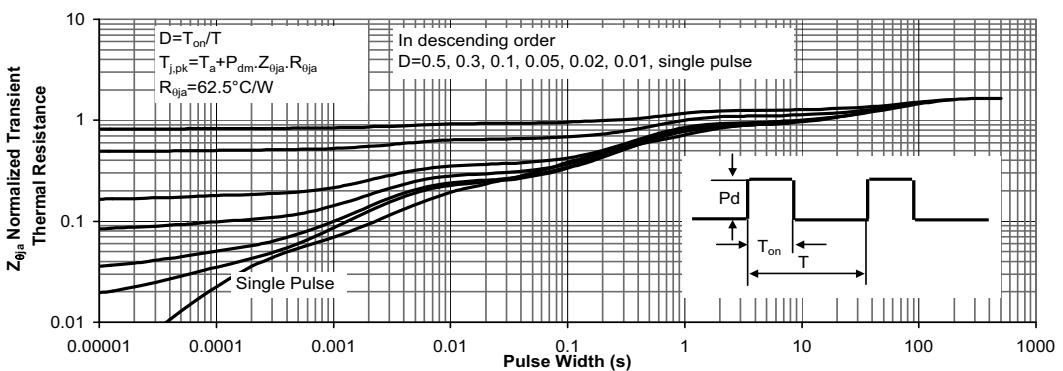


Figure 11: Normalized Maximum Transient Thermal Impedance